

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/547,687	BEHRENS ET A	AL.
Examiner	Art Unit	
Tan V. Mai	2193	

	SEARCHED		
Class	Subclass	Date	Examiner
708	333-323	5/18/2010	MAI

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	5/18/2010	MAI